Search Notes



Application/Control No.	Applicant(s)/Pater Reexamination
10/000 010) XIA ET A1

10/688,818

Examiner

Frederick C. Nicolas 3754

Applicant(s)/Patent under
Reexamination

XIA ET AL.

Art Unit

SEARCHED				
Class	Subclass	Date	Examiner	
222	209-210	8/4/2006	FN	
222	213-215	8/4/2006	FN	
222	631-633	8/4/2006	FN	
222	107,465.1	8/4/2006	FN	
222	541.9	8/4/2006	FN	
222	541.1	8/4/2006	FN	
222	153.06	8/4/2006	FN	
222	153.07	8/4/2006	FN	
422	100	8/4/2006	FN	
73	864.01	8/4/2006	FN	
73	864.02	8/4/2006	FN	
73	864.11	8/4/2006	FN	
73	864.53	8/4/2006	FN	
222	562-563	1/28/2007	FN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
222	209	1/28/2007	FN	
222	633	1/28/2007	FN	
222	541.1	1/28/2007	FN	
222 222 422	541.9 /562 /215 /100 64.01	1/28/2007	FN	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East and text search including inventors' name search.	8/4/2006	FN .
Updated search including additional search. Interference search also conducted.	1/28/2007	FN .
		·